

Notice of References Cited	Application/Control No. 10/772,655	Applicant(s)/Patent Under Reexamination LUO ET AL.	
	Examiner Katrina Fujita	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0153229	08-2004	Gokturk et al.	701/045
*	B	US-6,856,873	02-2005	Breed et al.	701/45
*	C	US-2002/0051571	05-2002	Jackway et al.	382/190
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Murphey et al., "Feature Extraction for a Multiple Pattern Classification Neural Network System", 2002, IEEE, 220-223
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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